

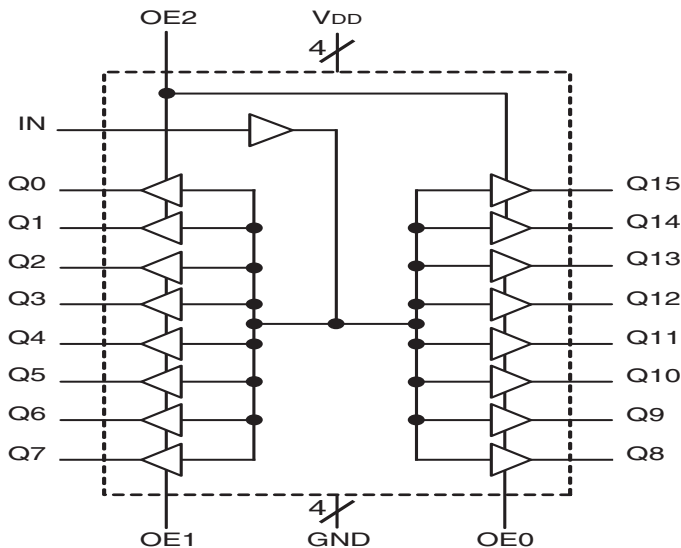
General Description

The 83115 is a low skew, 1-to-16 LVCMOS / LVTTL Fanout Buffer from IDT. The 83115 single-ended clock input accepts LVCMOS or LVTTL input levels. The 83115 operates at full 3.3V supply mode over the commercial temperature range. Guaranteed output and part-to-part skew characteristics make the 83115 ideal for those clock distribution applications demanding well defined performance and repeatability.

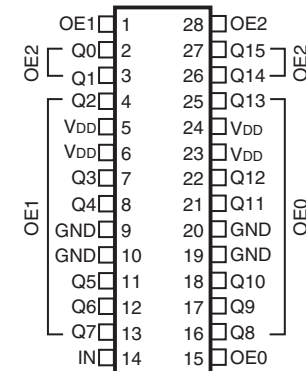
Features

- Sixteen LVCMOS / LVTTL outputs, 15Ω output impedance
- One LVCMOS / LVTTL clock input
- Maximum output frequency: 200MHz
- All inputs are 5V tolerant
- Output skew: 250ps (maximum)
- Part-to-part skew: 800ps (maximum)
- Additive phase jitter, RMS: 0.09ps (typical)
- Full 3.3V operating supply
- 0°C to 70°C ambient operating temperature
- Available in lead-free (RoHS 6) package

Block Diagram



Pin Assignment



83115

28-Lead SSOP, 150mil
9.9mm x 3.9mm x 1.5mm package body
R Package
Top View

Table 1. Pin Descriptions

Number	Name	Type		Description
1	OE1	Input	Pullup	Output enable pin. When LOW, forces outputs Q[2:7] to Hi-Z state. 5V tolerant. LVCMOS/LVTTL interface levels. See Table 3.
2, 3, 4, 7, 8, 11, 12, 13, 16, 17, 18, 21, 22, 25, 26, 27	Q0, Q1, Q2, Q3, Q4, Q5, Q6, Q7, Q8, Q9, Q10, Q11, Q12, Q13, Q14, Q15	Output		Single-ended clock outputs. 15Ω output impedance. LVCMOS/LVTTL interface levels.
5, 6, 23, 24	V _{DD}	Power		Positive supply pins.
9, 10, 19, 20	GND	Power		Power supply ground.
14	IN	Input	Pulldown	Single-ended clock input. 5V tolerant. LVCMOS/LVTTL interface levels.
15	OE0	Input	Pullup	Output enable pin. When LOW, forces outputs Q[8:13] to Hi-Z state. 5V tolerant. LVCMOS/LVTTL interface levels. See Table 3.
28	OE2	Input	Pullup	Output enable pin. When LOW, forces outputs Q[0:1] and Q[14:15] to Hi-Z state. 5V tolerant. LVCMOS/LVTTL interface levels. See Table 3.

NOTE: *Pullup* and *Pulldown* refer to internal input resistors. See Table 2, *Pin Characteristics*, for typical values.

Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			4		pF
R _{PULLUP}	Input Pullup Resistor			51		kΩ
R _{PULLDOWN}	Input Pulldown Resistor			51		kΩ
C _{PD}	Power Dissipation Capacitance (per output); NOTE 1	V _{DD} = 3.465V		11		pF
R _{OUT}	Output Impedance	V _{DD} = 3.3V		15		Ω

Function Tables

Table 3. OEx Function Table

Inputs			Outputs		
OE0	OE1	OE2	Control OE2 Q[0:1], Q[14:15]	Control OE1 Q[2:7]	Control OE0 Q[8:13]
0	0	0	Hi-Z	Hi-Z	Hi-Z
0	0	1	Active	Hi-Z	Hi-Z
0	1	0	Hi-Z	Active	Hi-Z
0	1	1	Active	Active	Hi-Z
1	0	0	Hi-Z	Hi-Z	Active
1	0	1	Active	Hi-Z	Active
1	1	0	Hi-Z	Active	Active
1	1	1	Active	Active	Active

Absolute Maximum Ratings

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V_{DD}	4.6V
Inputs, V_I	-0.5V to $V_{DD} + 0.5V$
Outputs, V_O	-0.5V to $V_{DD} + 0.5V$
Package Thermal Impedance, θ_{JA}	49°C/W (0 lfpm)
Storage Temperature, T_{STG}	-65°C to 150°C

DC Electrical Characteristics

Table 4A. Power Supply DC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $T_A = 0^\circ C$ to $70^\circ C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{DD}	Positive Supply Voltage		3.135	3.3	3.465	V
I_{DD}	Power Supply Current				50	mA

Table 4B. LVCMOS/LVTTL DC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $T_A = 0^\circ C$ to $70^\circ C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V_{IH}	Input High Voltage	OE0:OE2	2		$V_{DD} + 0.3$	V
		IN	2		$V_{DD} + 0.3$	V
V_{IL}	Input Low Voltage	OE0:OE2	-0.3		0.8	V
		IN	-0.3		1.3	V
I_{IH}	Input High Current	OE0:OE2	$V_{DD} = V_{IN} = 3.465V$		5	μA
		IN	$V_{DD} = V_{IN} = 3.465V$		150	μA
I_{IL}	Input Low Current	OE0:OE2	$V_{DD} = 3.465V, V_{IN} = 0V$	-150		μA
		IN	$V_{DD} = 3.465V, V_{IN} = 0V$	-5		μA
V_{OH}	Output High Voltage; NOTE 1	$V_{DD} = 3.3V \pm 5\%$	2.6			V
V_{OL}	Output Low Voltage; NOTE 1	$V_{DD} = 3.3V \pm 5\%$			0.5	V
I_{OZL}	Output Hi-Z Current Low				5	μA
I_{OZH}	Output Hi-Z Current High				5	μA

NOTE 1: Outputs terminated with 50Ω to $V_{DD}/2$. See Parameter Measurement Information, *Output Load Test Circuit diagram*.

AC Electrical Characteristics

Table 5. AC Characteristics, $V_{DD} = 3.3V \pm 5\%$, $T_A = 0^\circ C$ to $70^\circ C$

Parameter	Symbol	Test Conditions	Minimum	Typical	Maximum	Units
f_{MAX}	Output Frequency				200	MHz
t_{jit}	Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter Section	Integration Range: 12kHz – 20MHz		0.09		ps
t_{PLH}	Propagation Delay; NOTE 1	$f \leq 200MHz$	1.7	2.4	3.1	ns
$t_{sk(o)}$	Output Skew; NOTE 2, 4	Measured on the Rising Edge @ $V_{DD}/2$		150	250	ps
$t_{sk(pp)}$	Part-to-Part Skew; NOTE 3, 4	Measured on the Rising Edge @ $V_{DD}/2$			800	ps
t_R / t_F	Output Rise/Fall Time ⁴	20% to 80%	400		800	ps
odc	Output Duty Cycle		45		55	%
t_{EN}	Output Enable Time				20	ns
t_{DIS}	Output Disable Time				20	ns

All parameters measured at f_{MAX} unless noted otherwise.

NOTE 1: Measured from $V_{DD}/2$ of the input to $V_{DD}/2$ of the output.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at $V_{DD}/2$.

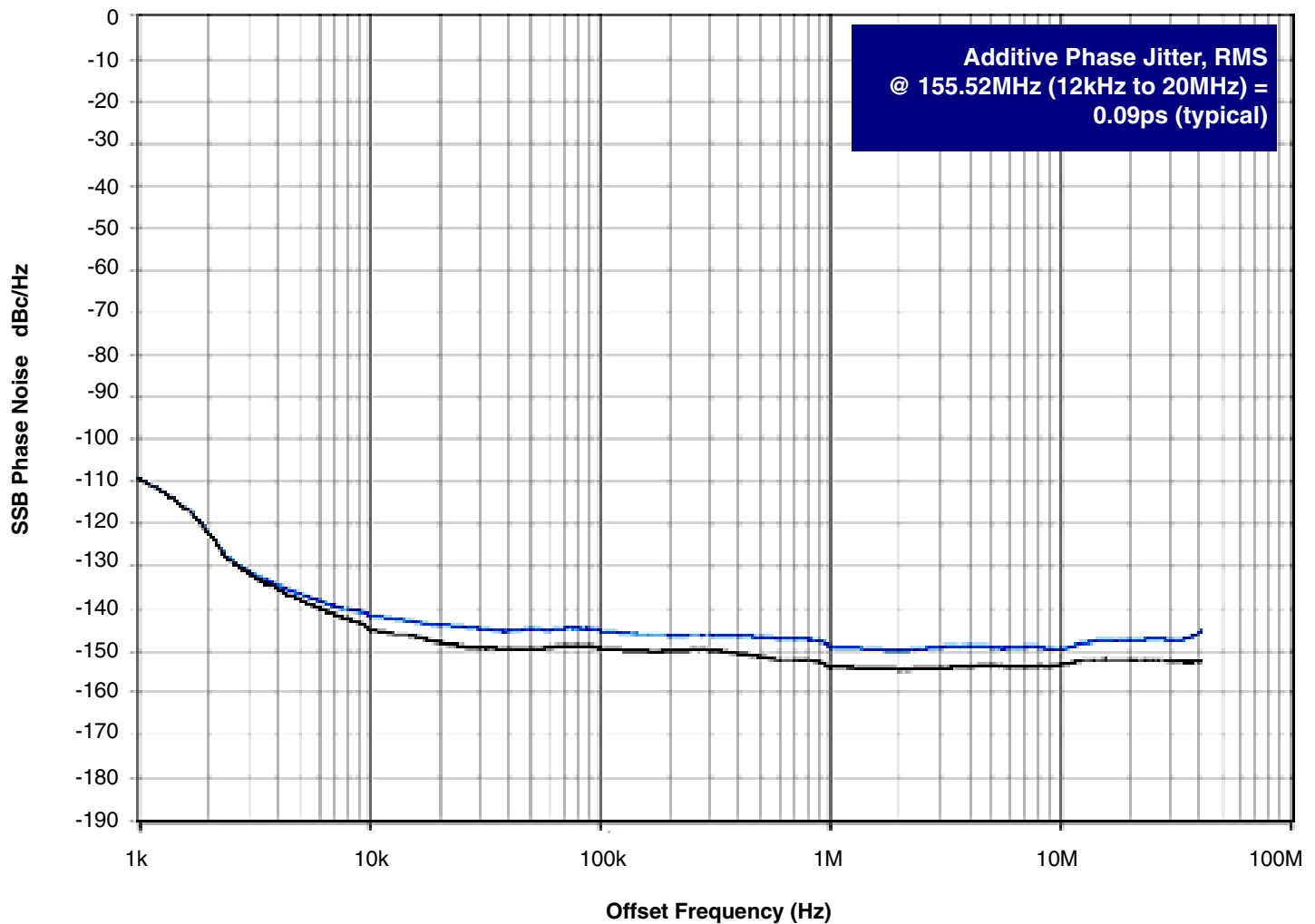
NOTE 3: Defined as skew between outputs on different devices operating at the same supply voltages and with equal load conditions. Using the same type of inputs on each device, the outputs are measured at $V_{DD}/2$.

NOTE 4: This parameter is defined in accordance with JEDEC Standard 65.

Additive Phase Jitter

The spectral purity in a band at a specific offset from the fundamental is called the **dBc Phase Noise**. This value is normally expressed using a Phase noise plot and is most often the specified plot in many applications. Phase noise is defined as the ratio of the noise power present in a 1Hz band at a specified offset from the fundamental frequency to the power value of the fundamental. This ratio is expressed in decibels (dBm) or a ratio of the power in the 1Hz band

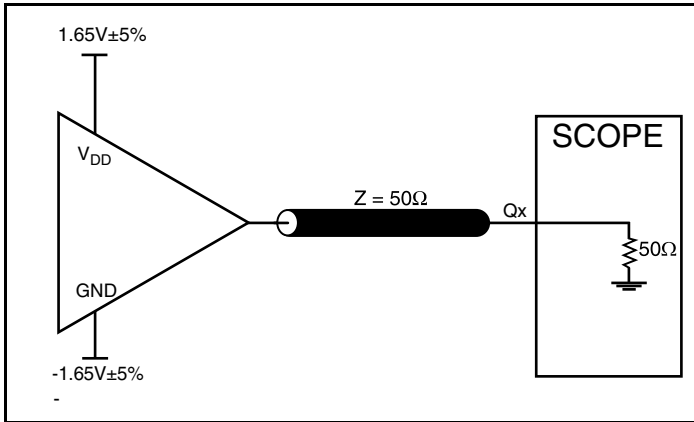
to the power in the fundamental. When the required offset is specified, the phase noise is called a **dBc** value, which simply means dBm at a specified offset from the fundamental. By investigating jitter in the frequency domain, we get a better understanding of its effects on the desired application over the entire time record of the signal. It is mathematically possible to calculate an expected bit error rate given a phase noise plot.



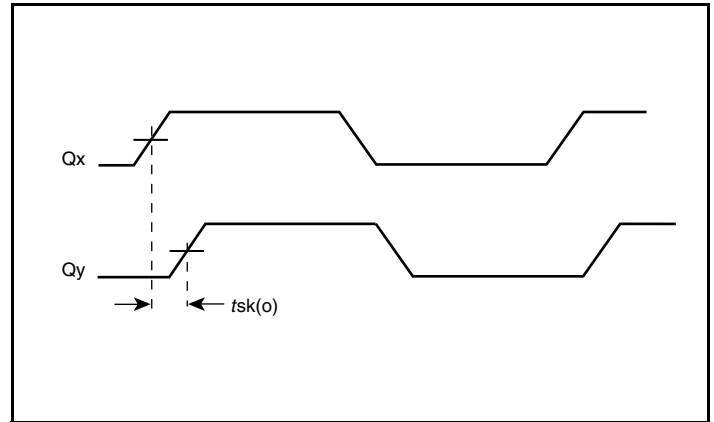
As with most timing specifications, phase noise measurements has issues relating to the limitations of the equipment. Often the noise floor of the equipment is higher than the noise floor of the

device. This is illustrated above. The device meets the noise floor of what is shown, but can actually be lower. The phase noise is dependent on the input source and measurement equipment.

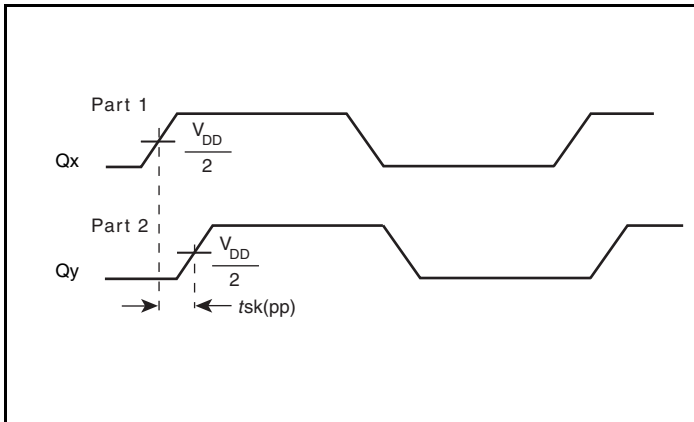
Parameter Measurement Information



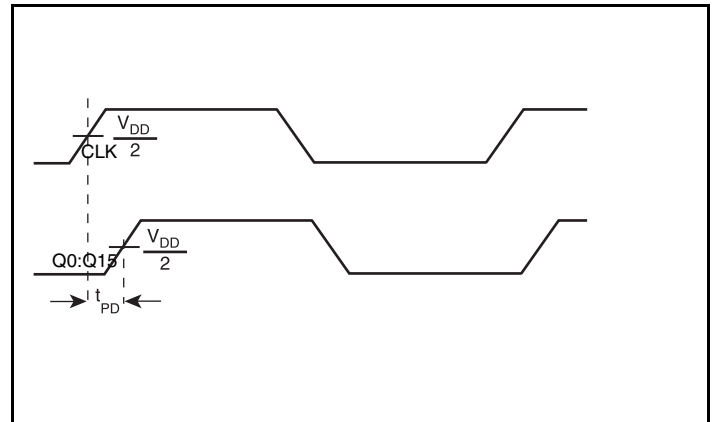
3.3V Output Load AC Test Circuit



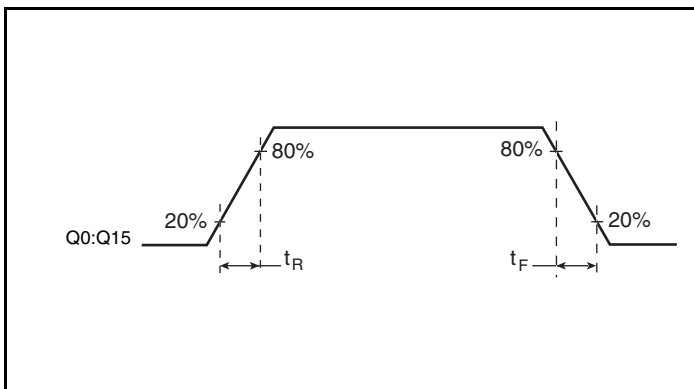
Output Skew



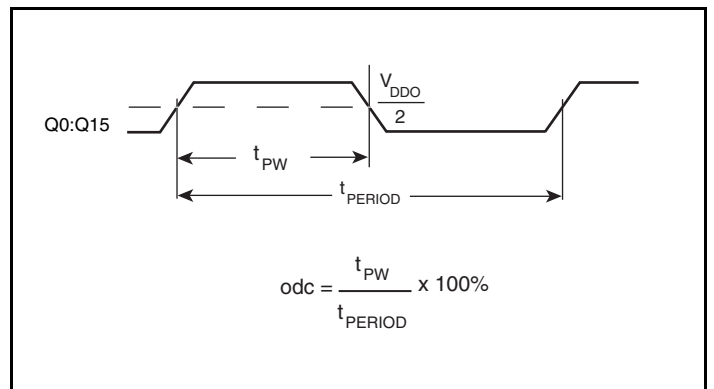
Part-to-Part Skew



Propagation Delay



Output Rise/Fall Time



Output Duty Cycle/Pulse Width/Period

Application Information

Recommendations for Unused Input and Output Pins

Inputs:

LVC MOS Control Pins

All control pins have internal pull-ups or pull-downs; additional resistance is not required but can be added for additional protection. A 1k Ω resistor can be used.

Outputs:

LVC MOS Outputs

All unused LVC MOS output can be left floating. There should be no trace attached.

Reliability Information

Table 6. θ_{JA} vs. Air Flow Table for a 28 Lead SSOP, 150MIL

θ_{JA} vs. Air Flow			
Linear Feet per Minute	0	200	500
Multi-Layer PCB, JEDEC Standard Test Boards	49°C/W	36°C/W	30°C/W

Transistor Count

The transistor count for 83115: 985

Package Outline and Package Dimension

Package Outline - G Suffix for 28 Lead SSOP

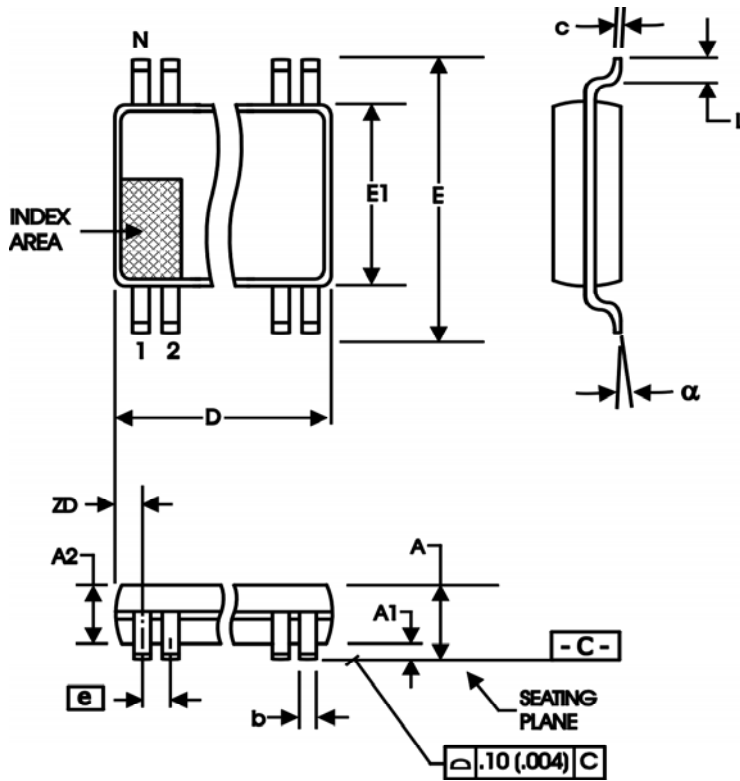


Table 7. Package Dimensions for 28 Lead SSOP

All Dimensions in Millimeters		
Symbol	Minimum	Maximum
N	28	
A	1.35	1.75
A1	0.10	0.25
A2		1.50
b	0.20	0.30
c	0.18	0.25
D	9.80	10.00
E	5.80	6.20
E1	3.80	4.00
e	0.635 Basic	
L	0.40	1.27
α	0°	8°
ZD	0.84 Ref	

Reference Document: JEDEC Publication 95, MO-137

Ordering Information

Table 8. Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
ICS83115BRLF	ICS83115BRLF	"Lead-Free" 28 Lead SSOP	Tube	0°C to 70°C
ICS83115BRLFT	ICS83115BRLF	"Lead-Free" 28 Lead SSOP	Tape & Reel	0°C to 70°C

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.

Revision History Sheet

Rev	Table	Page	Description of Change	Date
C	T5	4	AC Characteristics Table - changed Output Rise/Fall Time limits from 650ps min./1150ps max. to 400ps min./800ps max.	3/14/08
C	T8	9	Ordering Information - removed leaded devices. Updated data sheet format.	3/20/15



Corporate Headquarters
6024 Silver Creek Valley Road
San Jose, CA 95138 USA

Sales
1-800-345-7015 or 408-284-8200
Fax: 408-284-2775
www.IDT.com

Tech Support
email: clocks@idt.com

DISCLAIMER Integrated Device Technology, Inc. (IDT) and its subsidiaries reserve the right to modify the products and/or specifications described herein at any time and at IDT's sole discretion. All information in this document, including descriptions of product features and performance, is subject to change without notice. Performance specifications and the operating parameters of the described products are determined in the independent state and are not guaranteed to perform the same way when installed in customer products. The information contained herein is provided without representation or warranty of any kind, whether express or implied, including, but not limited to, the suitability of IDT's products for any particular purpose, an implied warranty of merchantability, or non-infringement of the intellectual property rights of others. This document is presented only as a guide and does not convey any license under intellectual property rights of IDT or any third parties.

IDT's products are not intended for use in applications involving extreme environmental conditions or in life support systems or similar devices where the failure or malfunction of an IDT product can be reasonably expected to significantly affect the health or safety of users. Anyone using an IDT product in such a manner does so at their own risk, absent an express, written agreement by IDT.

While the information presented herein has been checked for both accuracy and reliability, Integrated Device Technology (IDT) assumes no responsibility for either its use or for the infringement of any patents or other rights of third parties, which would result from its use. No other circuits, patents, or licenses are implied. This product is intended for use in normal commercial applications. Any other applications, such as those requiring extended temperature ranges, high reliability or other extraordinary environmental requirements are not recommended without additional processing by IDT. IDT reserves the right to change any circuitry or specifications without notice. IDT does not authorize or warrant any IDT product for use in life support devices or critical medical instruments.

Integrated Device Technology, IDT and the IDT logo are registered trademarks of IDT. Product specification subject to change without notice. Other trademarks and service marks used herein, including protected names, logos and designs, are the property of IDT or their respective third party owners.

Copyright ©2015 Integrated Device Technology, Inc.. All rights reserved.